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**1 2003 Digest of Technical Papers. International Conference on Consumer Electronics (Cat. No.03CH37416)**

Consumer Electronics, 2003. ICCE. 2003 IEEE International Conference on , 1 June 2003

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## 2 Watermark embedded DCT indexing keys for portable imaging device

*Armstrong, A.; Jiang, J.;*

Consumer Electronics, 2002. ICCE. 2002 Digest of Technical Papers. International Conference on , 18-20 June 2002

Pages:126 - 127

[\[Abstract\]](#)   [\[PDF Full-Text \(328 KB\)\]](#)   **IEEE CNF**

### 3 A watermarking scheme for digital cinema

*Haitsma, J.; Kalker, T.;*

Image Processing, 2001. Proceedings. 2001 International Conference on , Vol 2 , 7-10 Oct. 2001

Pages:487 - 489 vol.2

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